DATA SHEET

NEC

MOS FIELD EFFECT TRANSISTOR
μPA2721AGR

SWITCHING
N-CHANNEL POWER MOS FET

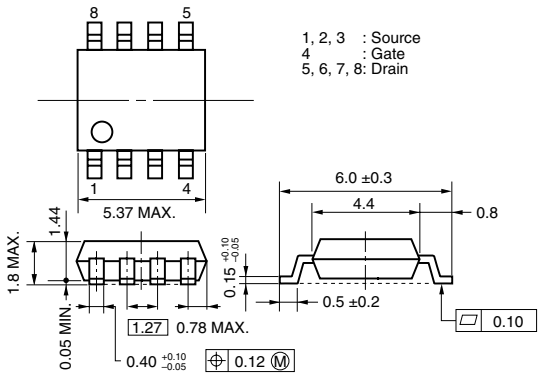
DESCRIPTION

The μPA2721AGR is N-channel MOS Field Effect Transistor designed for power management applications of a notebook computer.

FEATURES

- Low on-state resistance
  $R_{DS(on)1}$ = 4.3 mΩ MAX. (V_{GS} = 10 V, I_D = 10 A)
  $R_{DS(on)2}$ = 10 mΩ MAX. (V_{GS} = 5.0 V, I_D = 10 A)
- Low input capacitance
  C_{iss} = 7100 pF TYP. (V_{DS} = 10 V, V_{GS} = 0 V)
- Built-in gate protection diode
- Small and surface mount package (Power SOP8)
- RoHS Compliant

PACKAGE DRAWING (Unit: mm)



ORDERING INFORMATION

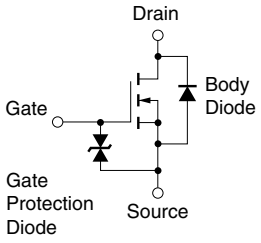
PART NUMBER	LEAD PLATING	PACKING	PACKAGE
μPA2721AGR-E1-AT Note	Pure Sn	Tape 2500 p/reel	Power SOP8 0.08 g TYP.
μPA2721AGR-E2-AT Note			

Note Pb-free (This product does not contain Pb in external electrode and other parts.)

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, All terminals are connected.)

Drain to Source Voltage (V_{GS} = 0 V)	V_{DSS}	30	V
Gate to Source Voltage (V_{DS} = 0 V)	V_{GSS}	±20	V
Drain Current (DC)	$I_{D(DC)}$	±19	A
Drain Current (pulse) Note1	$I_{D(pulse)}$	±200	A
Total Power Dissipation Note2	P_{T1}	1.1	W
Total Power Dissipation (PW = 10 sec) Note2	P_{T2}	2.5	W
Channel Temperature	T_{ch}	150	°C
Storage Temperature	T_{stg}	−55 to +150	°C
Single Avalanche Current Note3	I_{AS}	19	A
Single Avalanche Energy Note3	E_{AS}	36	mJ

EQUIVALENT CIRCUIT



Notes 1. PW ≤ 10 μs, Duty Cycle ≤ 1%

2. Mounted on glass epoxy board of 25.4 mm x 25.4 mm x 0.8 mmt

3. Starting T_{ch} = 25°C, V_{DD} = 15 V, R_G = 25 Ω, V_{GS} = 20 → 0 V, L = 100 μH

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

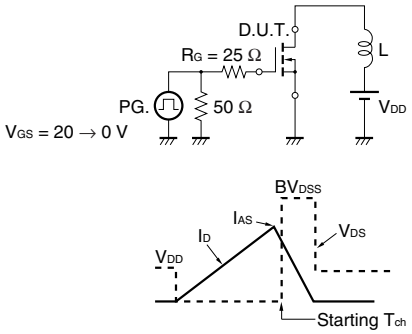
Document No. G18705EJ1V0DS00 (1st edition)
Date Published September 2008 NS
Printed in Japan

ELECTRICAL CHARACTERISTICS (T_A = 25°C, All terminals are connected.)

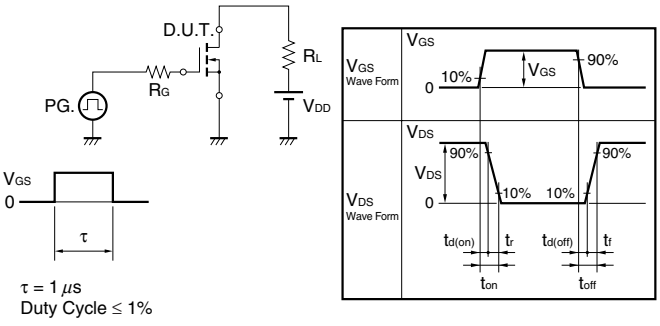
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 30 V, V_{GS} = 0 V			1	μA
Gate Leakage Current	I_{GSS}	V_{GS} = ±20 V, V_{DS} = 0 V			±10	μA
Gate to Source Cut-off Voltage	$V_{GS(off)}$	V_{DS} = 10 V, I_D = 1 mA	1.5		3.0	V
Forward Transfer Admittance Note	$\|y_{fs}\|$	V_{DS} = 10 V, I_D = 10 A	11			S
Drain to Source On-state Resistance Note	$R_{DS(on)1}$	V_{GS} = 10 V, I_D = 10 A		3.6	4.3	mΩ
	$R_{DS(on)2}$	V_{GS} = 5.0 V, I_D = 10 A		4.7	10	mΩ
Input Capacitance	C_{iss}	V_{DS} = 10 V,		7100		pF
Output Capacitance	C_{oss}	V_{GS} = 0 V,		930		pF
Reverse Transfer Capacitance	C_{rss}	f = 1 MHz		490		pF
Turn-on Delay Time	$t_{d(on)}$	V_{DD} = 15 V, I_D = 10 A,		33		ns
Rise Time	t_r	V_{GS} = 10 V,		31		ns
Turn-off Delay Time	$t_{d(off)}$	R_G = 10 Ω		112		ns
Fall Time	t_f			32		ns
Total Gate Charge	Q_G	V_{DD} = 15 V,		52		nC
Gate to Source Charge	Q_{GS}	V_{GS} = 5 V,		20		nC
Gate to Drain Charge	Q_{GD}	I_D = 19 A		20		nC
Body Diode Forward Voltage Note	$V_{F(S-D)}$	I_F = 19 A, V_{GS} = 0 V		0.8		V
Reverse Recovery Time	t_{rr}	I_F = 19 A, V_{GS} = 0 V,		41		ns
Reverse Recovery Charge	Q_{rr}	di/dt = 100 A/μs		44		nC

Note Pulsed

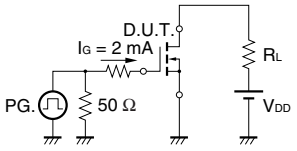
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME

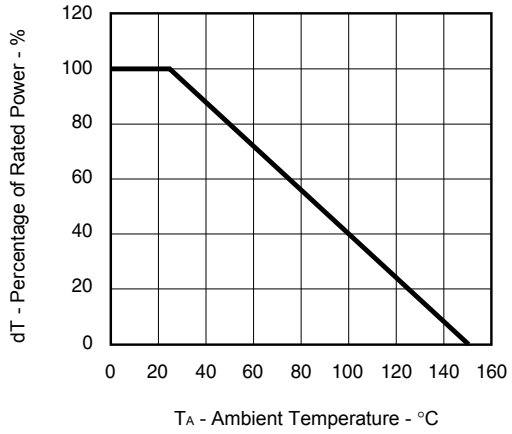


TEST CIRCUIT 3 GATE CHARGE

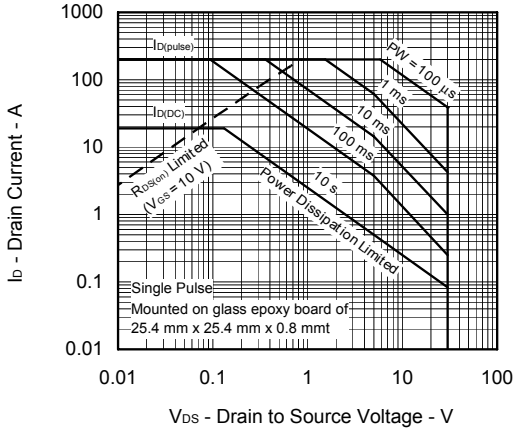


TYPICAL CHARACTERISTICS (T_A = 25°C)

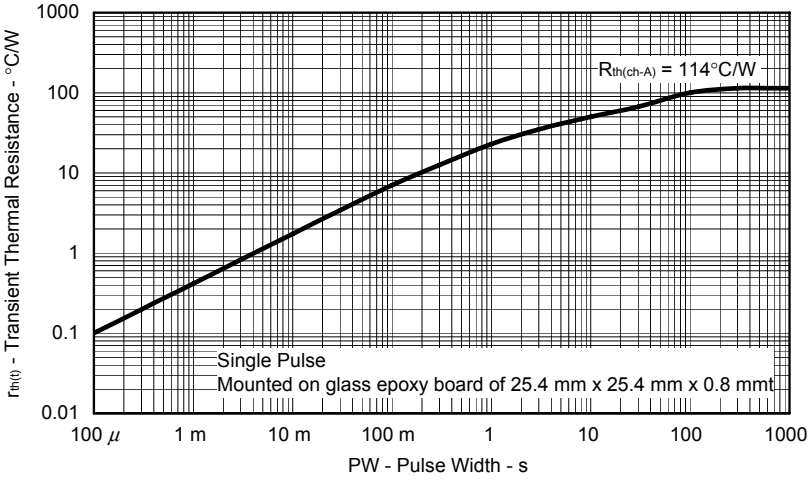
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



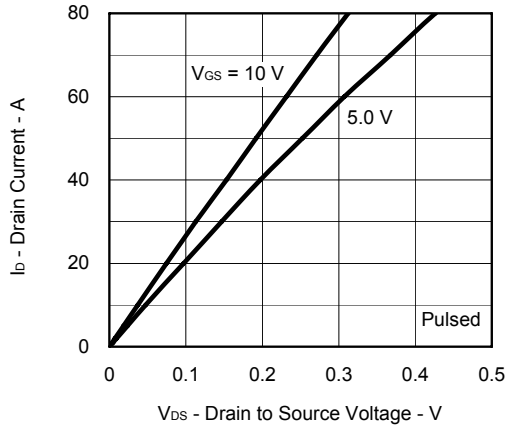
FORWARD BIAS SAFE OPERATING AREA



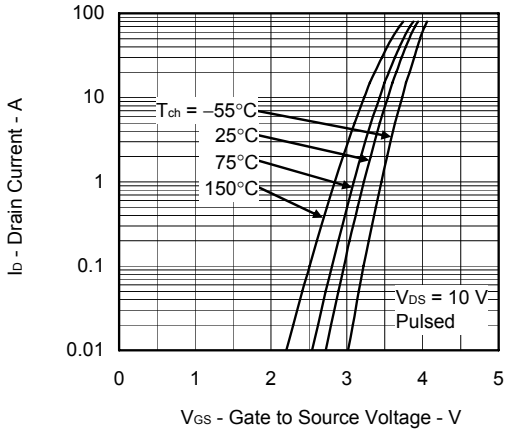
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



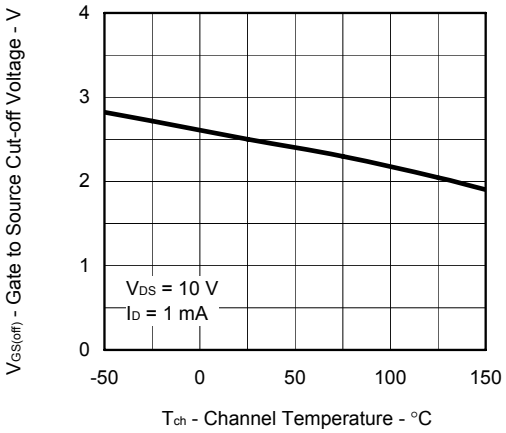
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



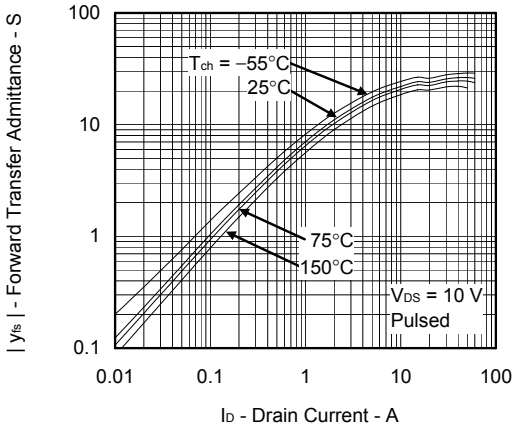
FORWARD TRANSFER CHARACTERISTICS



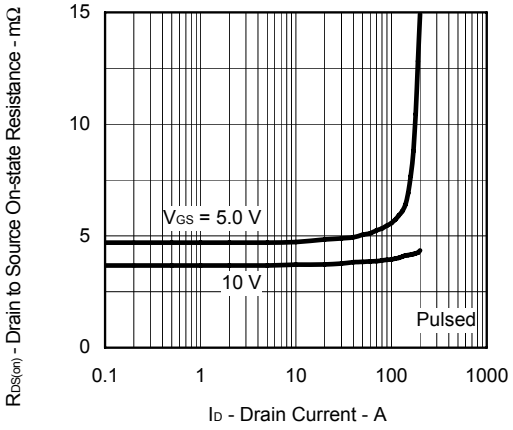
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



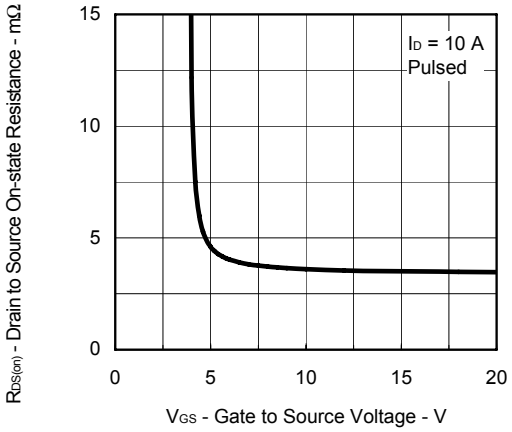
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



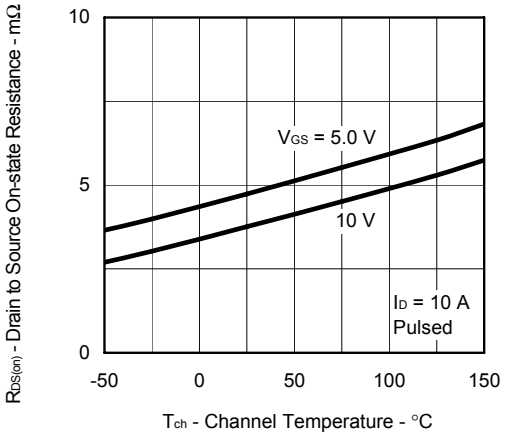
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



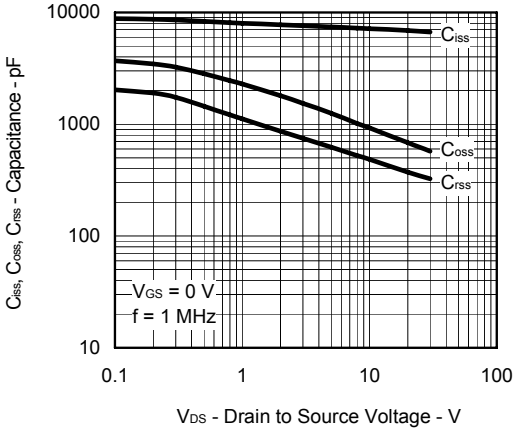
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



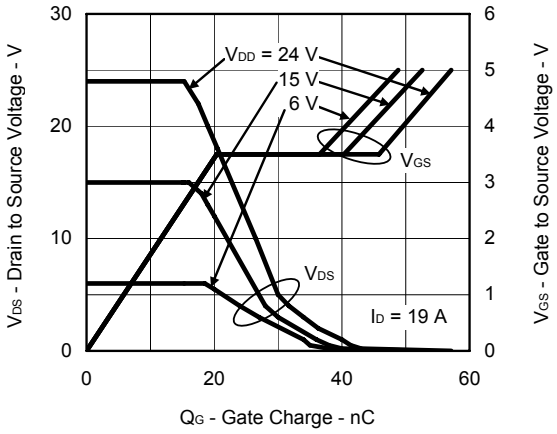
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



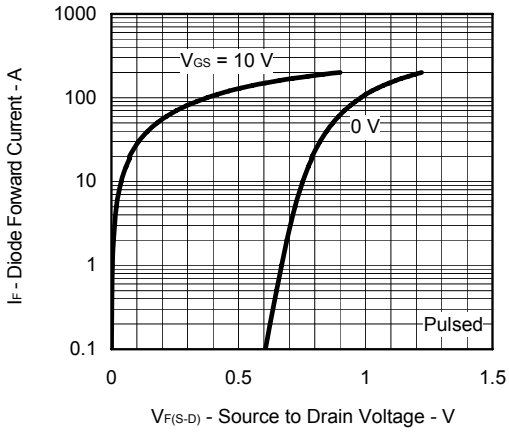
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



- **The information in this document is current as of September, 2008. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC Electronics data sheets or data books, etc., for the most up-to-date specifications of NEC Electronics products. Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.**
- No part of this document may be copied or reproduced in any form or by any means without the prior written consent of NEC Electronics. NEC Electronics assumes no responsibility for any errors that may appear in this document.
- NEC Electronics does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from the use of NEC Electronics products listed in this document or any other liability arising from the use of such products. No license, express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC Electronics or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of a customer's equipment shall be done under the full responsibility of the customer. NEC Electronics assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC Electronics endeavors to enhance the quality, reliability and safety of NEC Electronics products, customers agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize risks of damage to property or injury (including death) to persons arising from defects in NEC Electronics products, customers must incorporate sufficient safety measures in their design, such as redundancy, fire-containment and anti-failure features.
- NEC Electronics products are classified into the following three quality grades: "Standard", "Special" and "Specific".
  The "Specific" quality grade applies only to NEC Electronics products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of an NEC Electronics product depend on its quality grade, as indicated below. Customers must check the quality grade of each NEC Electronics product before using it in a particular application.
  "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots.
  "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support).
  "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC Electronics products is "Standard" unless otherwise expressly specified in NEC Electronics data sheets or data books, etc. If customers wish to use NEC Electronics products in applications not intended by NEC Electronics, they must contact an NEC Electronics sales representative in advance to determine NEC Electronics' willingness to support a given application.

(Note)
(1) "NEC Electronics" as used in this statement means NEC Electronics Corporation and also includes its majority-owned subsidiaries.
(2) "NEC Electronics products" means any product developed or manufactured by or for NEC Electronics (as defined above).

M8E 02. 11-1